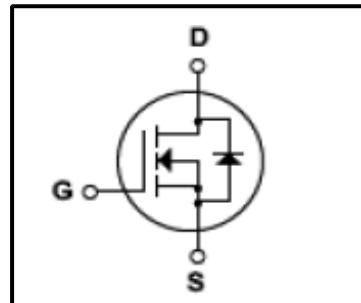


**Silicon N-Channel MOSFET**
**Features**

- 7.5A,600V, $R_{DS(on)}$ (Max1.2Ω)@ $V_{GS}=10V$
- Ultra-low Gate charge(Typical 28nC)
- Fast Switching Capability
- 100%Avalanche Tested
- Maximum Junction Temperature Range(150°C)


**General Description**

This Power MOSFET is produced using Winsemi's advanced planar stripe,VDMOS technology.this latest technology has been especially designed to minimize on-state resistance, have a high rugged avalanche characteristics .This devices is specially well suited for half bridge and full bridge resonant topology line a electronic lamp ballast, high efficiency switched mode power supplies, active power factor correction.


**Absolute Maximum Ratings**

| Symbol         | Parameter                                      | Value    | Units |
|----------------|--|----------|-------|
| $V_{DSS}$      | Drain Source Voltage                           | 600      | V     |
| $I_D$          | Continuous Drain Current(@ $T_c=25^\circ C$ )  | 7.5      | A     |
|                | Continuous Drain Current(@ $T_c=100^\circ C$ ) | 4.5      | A     |
| $I_{DM}$       | Drain Current Pulsed                           | (Note1)  | A     |
| $V_{GS}$       | Gate to Source Voltage                         | $\pm 30$ | V     |
| $E_{AS}$       | Single Pulsed Avalanche Energy                 | (Note2)  | mJ    |
| $E_{AR}$       | Repetitive Avalanche Energy                    | (Note1)  | mJ    |
| $dv/dt$        | Peak Diode Recovery $dv/dt$                    | (Note3)  | V/ns  |
| $P_D$          | Total Power Dissipation(@ $T_c=25^\circ C$ )   | 142      | W     |
|                | Derating Factor above 25°C                     | 1.13     | W/°C  |
| $T_J, T_{stg}$ | Junction and Storage Temperature               | -55~150  | °C    |
| $T_L$          | Channel Temperature                            | 300      | °C    |

**Thermal Characteristics**

| Symbol    | Parameter                                 | Value |     |      | Units |
|-----------|---|-------|-----|------|-------|
|           |   | Min   | Typ | Max  |       |
| $R_{QJC}$ | Thermal Resistance , Junction -to -Case   | -     | -   | 0.88 | °C/W  |
| $R_{QCS}$ | Thermal Resistance , Case-to-Sink         | 0.5   | -   | -    | °C/W  |
| $R_{QJA}$ | Thermal Resistance , Junction-to -Ambient | -     | -   | 62.5 | °C/W  |

**Electrical Characteristics(Tc=25°C)**

| Characteristics                                | Symbol               | Test Condition  | Min   | Type | Max  | Unit |    |
|--|----------------------|---|---|------|------|------|----|
| Gate leakage current                           | I <sub>GSS</sub>     | V <sub>GS</sub> =±30V,V <sub>DS</sub> =0V                               | -   | -    | ±100 | nA   |    |
| Gate-source breakdown voltage                  | V <sub>(BR)GSS</sub> | I <sub>G</sub> =±10 μA,V <sub>DS</sub> =0V                              | ±30   | -    | -    | V    |    |
| Drain cut -off current                         | I <sub>DSS</sub>     | V <sub>DS</sub> =600V,V <sub>GS</sub> =0V                               | -   | -    | 10   | μA   |    |
|  |                      | V <sub>DS</sub> =480V,Tc=125°C  | -   | -    | 100  | μA   |    |
| Drain -source breakdown voltage                | V <sub>(BR)DSS</sub> | I <sub>D</sub> =250 μA,V <sub>GS</sub> =0V                              | 600   | -    | -    | V    |    |
| Gate threshold voltage                         | V <sub>GS(th)</sub>  | V <sub>DS</sub> =10V,I <sub>D</sub> =250 μA                             | 2   | -    | 4    | V    |    |
| Drain -source ON resistance                    | R <sub>DS(ON)</sub>  | V <sub>GS</sub> =10V,I <sub>D</sub> =3.75A                              | -   | 0.8  | 1.2  | Ω    |    |
| Forward Transconductance                       | g <sub>fs</sub>      | V <sub>DS</sub> =50V,I <sub>D</sub> =3.75A                              | -   | 6.4  | -    | S    |    |
| Input capacitance                              | C <sub>iss</sub>     | V <sub>DS</sub> =25V,<br>V <sub>GS</sub> =0V,<br>f=1MHz                 | -   | 1120 | 1350 | pF   |    |
| Reverse transfer capacitance                   | C <sub>rss</sub>     |   | -   | 23   | 30   |      |    |
| Output capacitance                             | C <sub>oss</sub>     |   | -   | 115  | 150  |      |    |
| Switching time                                 | Turn-on Rise time    | tr  | V <sub>DD</sub> =200V,<br>I <sub>D</sub> =7.5A<br>R <sub>G</sub> =25Ω | -    | 80   | 170  | ns |
|  | Turn-on delay time   | t <sub>on</sub>   |   | -    | 30   | 70   |    |
|  | Turn-off Fall time   | t <sub>f</sub>  |   | -    | 60   | 110  |    |
|  | Turn-off delay time  | t <sub>off</sub>  |   | -    | 125  | 260  |    |
| Total gate charge(gate-source plus gate-drain) | Q <sub>g</sub>       | V <sub>DD</sub> =480V,<br>V <sub>GS</sub> =10V,<br>I <sub>D</sub> =7.5A | -   | 28   | 36   | nC   |    |
| Gate-source charge                             | Q <sub>gs</sub>      |   | -   | 7    | -    |      |    |
| Gate-drain("miller") Charge                    | Q <sub>gd</sub>      |   | -   | 14.5 | -    |      |    |

**Source-Drain Ratings and Characteristics(Ta=25°C)**

| Characteristics                  | Symbol           | Test Condition  | Min | Type | Max  | Unit |
|----------------------------------|------------------|---|-----|------|------|------|
| Continuous drain reverse current | I <sub>DR</sub>  | -   | -   | -    | 7.5  | A    |
| Pulse drain reverse current      | I <sub>DRP</sub> | -   | -   | -    | 29.6 | A    |
| Forward voltage(diode)           | V <sub>DSF</sub> | I <sub>DR</sub> =7.5A,V <sub>GS</sub> =0V                                       | -   | -    | 1.4  | V    |
| Reverse recovery time            | t <sub>rr</sub>  | I <sub>DR</sub> =7.5A,V <sub>GS</sub> =0V,<br>dI <sub>DR</sub> / dt =100 A / μs | -   | 320  | -    | ns   |
| Reverse recovery charge          | Q <sub>rr</sub>  |   | -   | 2.4  | -    | μC   |

Note 1.Repeativity rating :pulse width limited by junction temperature

2.L=18.5mH I<sub>AS</sub>=7.5A,V<sub>DD</sub>=50V,R<sub>G</sub>=0Ω,Starting T<sub>J</sub>=25°C

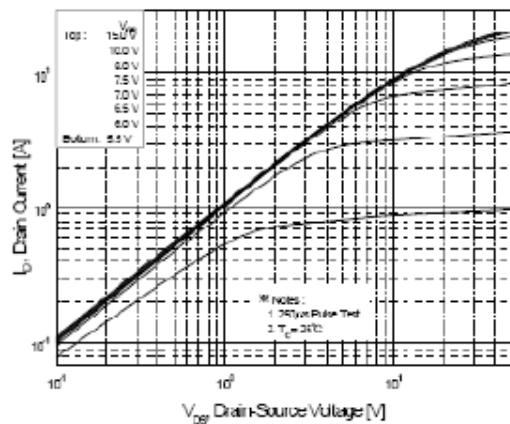
3.I<sub>SD</sub>≤7.5A,di/dt≤200A/us,V<sub>DD</sub><BV<sub>DSS</sub>,STARTING T<sub>J</sub>=25°C

4.Pulse Test:Pulse Width≤300us,Duty Cycle≤2%

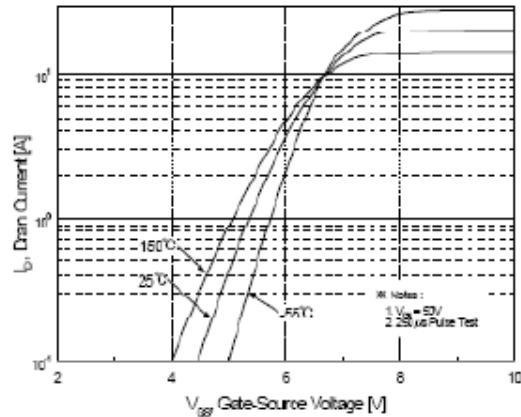
5. Essentially independent of operating temperature.

This transistor is an electrostatic sensitive device

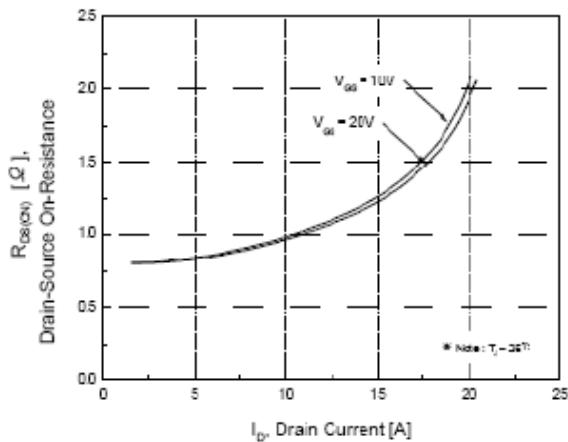
Please handle with caution



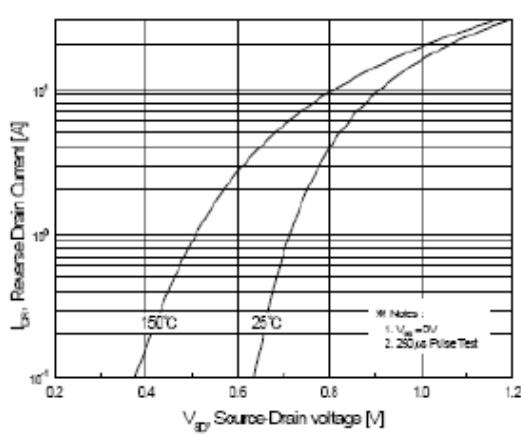
**Fig.1 On State Characteristics**



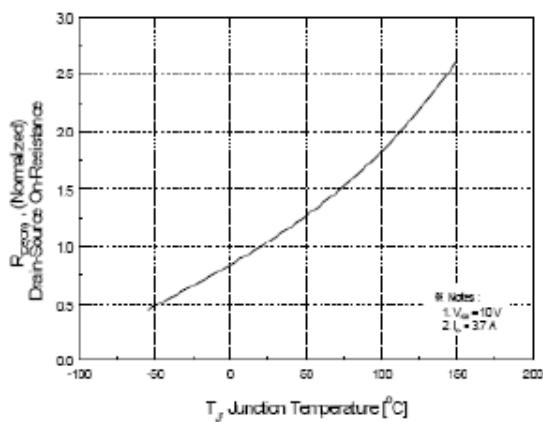
**Fig.2 Transfer Current Characteristics**



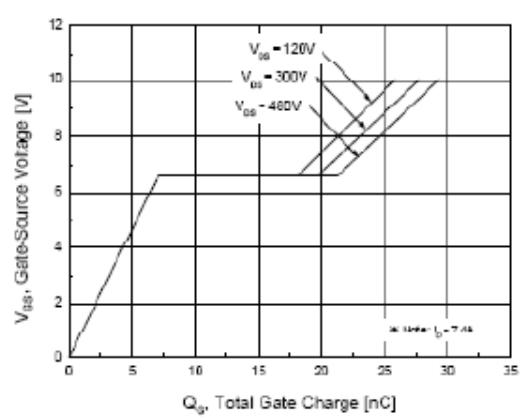
**Fig.3 On-Resistance Variation vs Drain Current**



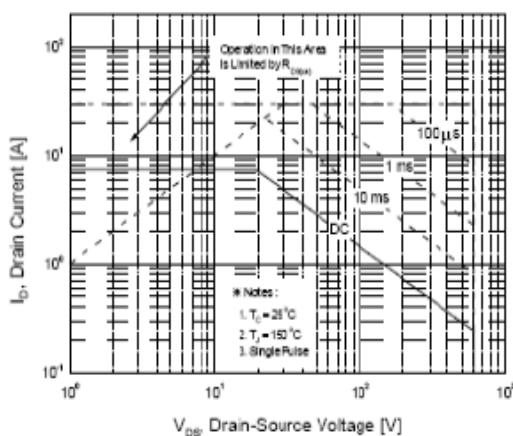
**Fig.4 Body Diode Forward Voltage Variation with Source Current and Temperature**



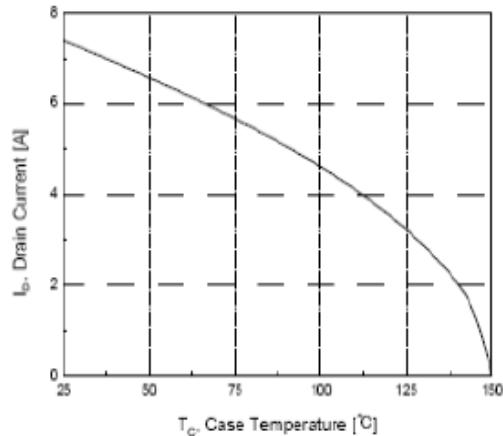
**Fig.5 On-Resistance Variation vs Junction Temperature**



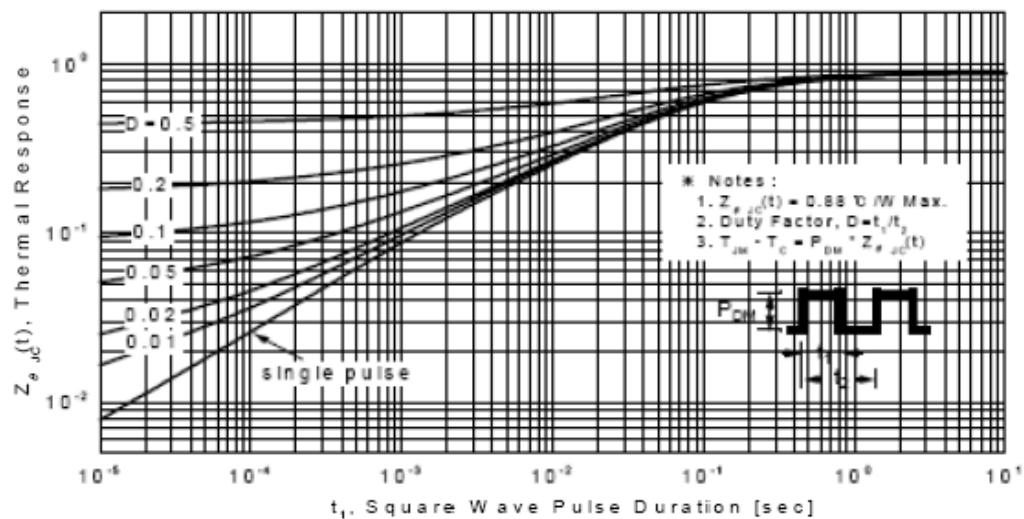
**Fig.6 Gate Charge Characteristics**



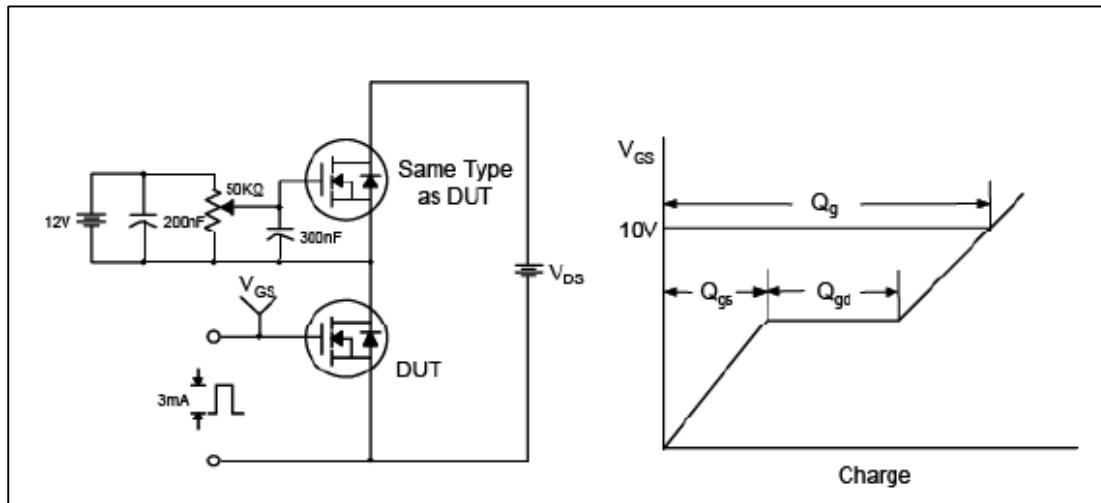
**Fig.7 Maximum Safe Operation Area**



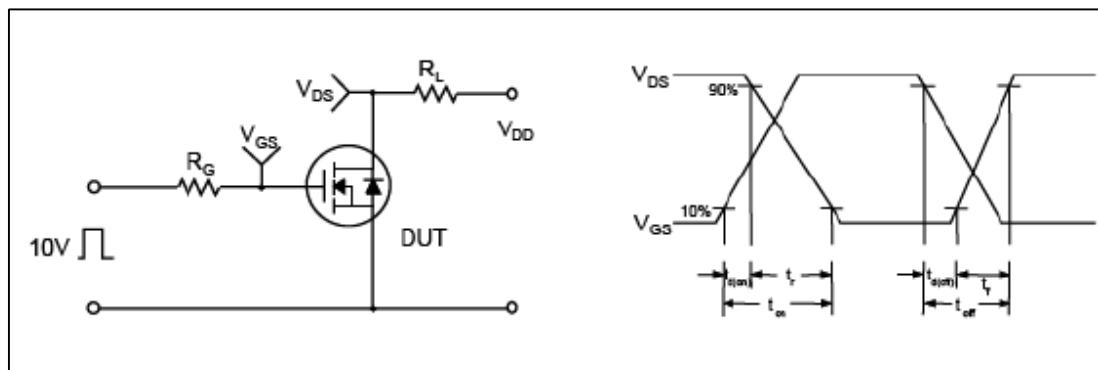
**Fig.8 Maximum Drain Current vs Case Temperature**



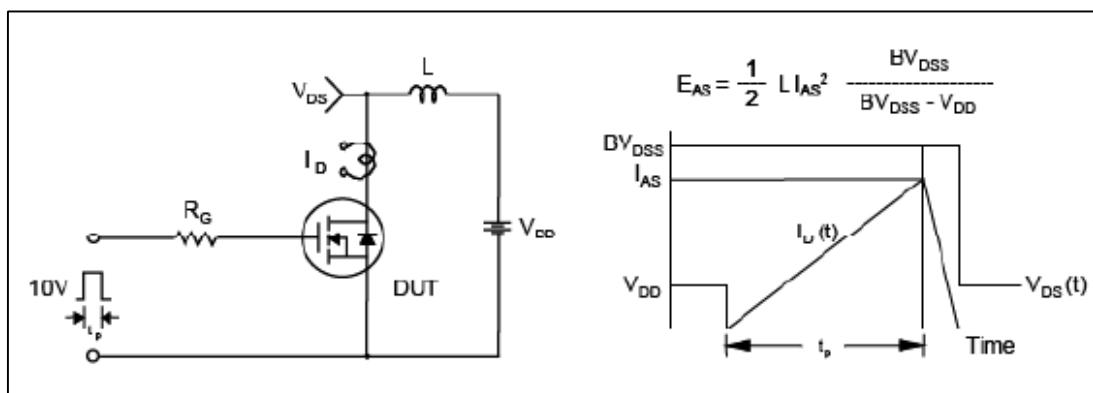
**Fig.9 Transient Thermal Response Curve**



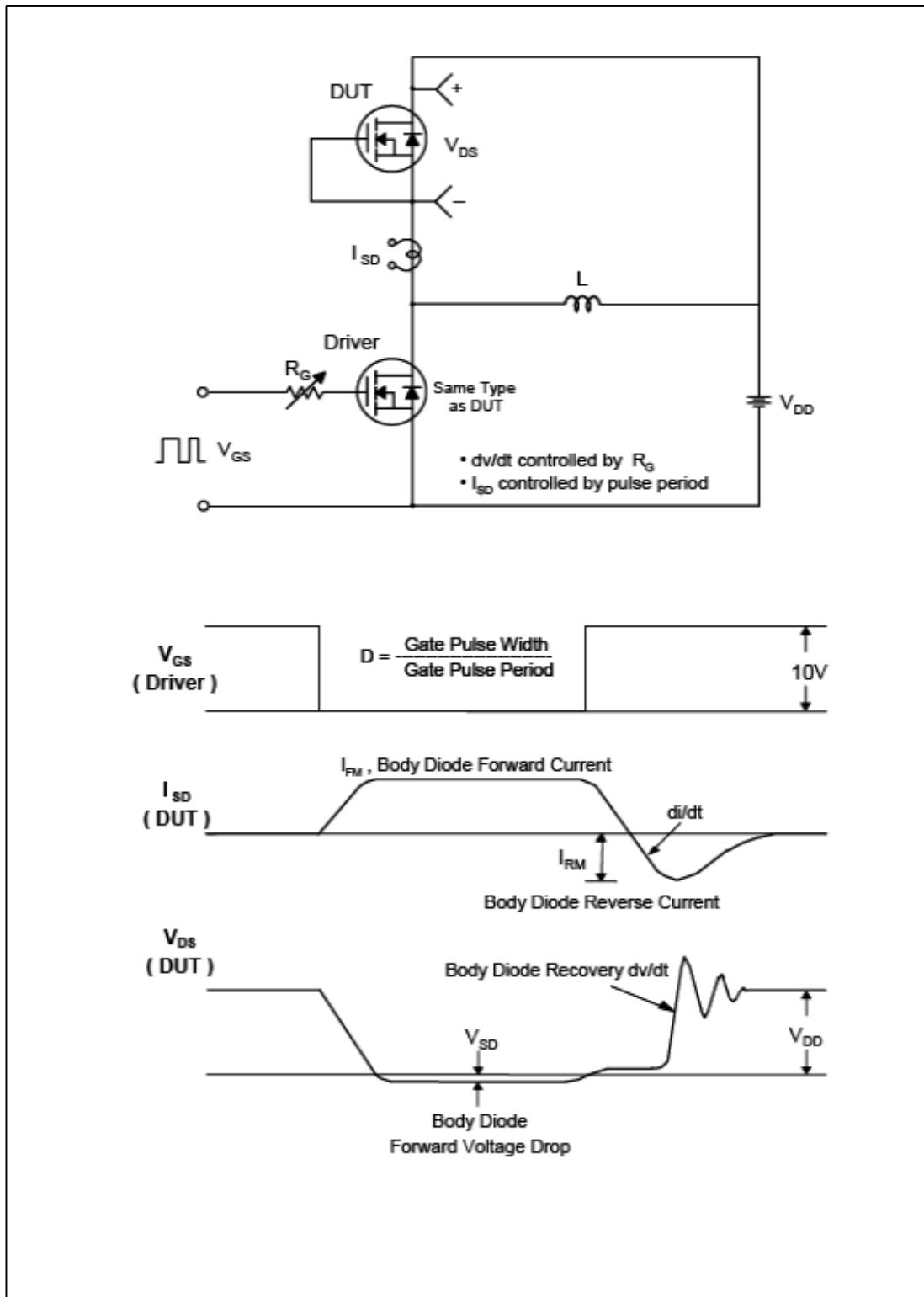
**Fig.10 Gate Test Circuit & Waveform**



**Fig.11 Resistive Switching Test Circuit & Waveform**



**Fig.12 Unclamped Inductive Switching Test Circuit & Waveform**



**Fig.13 Peak Diode Recovery  $dv/dt$  Test Circuit & Waveform**

**TO-220 Package Dimension**

